

ISL9V3040D3S / ISL9V3040S3S / ISL9V3040P3 / ISL9V3040S3

EcoSPARK® 300mJ, 400V, N-Channel Ignition IGBT

General Description

The ISL9V3040D3S, ISL9V3040S3S, ISL9V3040P3, and ISL9V3040S3 are the next generation ignition IGBTs that offer outstanding SCIS capability in the space saving D-Pak (TO-252), as well as the industry standard D²-Pak (TO-263), and TO-262 and TO-220 plastic packages. This device is intended for use in automotive ignition circuits, specifically as a coil driver. Internal diodes provide voltage clamping without the need for external components.

EcoSPARK® devices can be custom made to specific clamp voltages. Contact your nearest Fairchild sales office for more information.

Formerly Developmental Type 49362

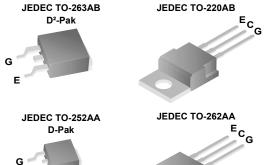
Applications

- · Automotive Ignition Coil Driver Circuits
- · Coil- On Plug Applications

Features

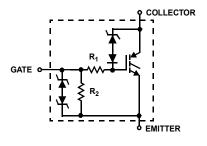
- · Space saving D-Pak package availability
- SCIS Energy = 300mJ at T_{.I} = 25°C
- · Logic Level Gate Drive

Package



COLLECTOR (FLANGE)

Symbol



Device Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units	
BV _{CER}	Collector to Emitter Breakdown Voltage (I _C = 1 mA)	430	V	
BV _{ECS}	Emitter to Collector Voltage - Reverse Battery Condition (I _C = 10 mA)	24	V	
E _{SCIS25}	At Starting $T_J = 25$ °C, $I_{SCIS} = 14.2A$, $L = 3.0$ mHy	300	mJ	
E _{SCIS150}	At Starting T _J = 150°C, I _{SCIS} = 10.6A, L = 3.0 mHy	170	mJ	
I _{C25}	Collector Current Continuous, At T _C = 25°C, See Fig 9	21	Α	
I _{C110}	Collector Current Continuous, At T _C = 110°C, See Fig 9	17	Α	
V_{GEM}	Gate to Emitter Voltage Continuous	±10	V	
P _D	Power Dissipation Total T _C = 25°C	150	W	
	Power Dissipation Derating T _C > 25°C	1.0	W/°C	
TJ	Operating Junction Temperature Range	-40 to 175	°C	
T _{STG}	Storage Junction Temperature Range	-40 to 175	°C	
T _L	Max Lead Temp for Soldering (Leads at 1.6mm from Case for 10s)	300	°C	
T _{pkg}	Max Lead Temp for Soldering (Package Body for 10s)	260	°C	
ESD	Electrostatic Discharge Voltage at 100pF, 1500Ω	4	kV	

Device Marking		Device	Package)	Reel Size	Tape Width		Quantity	
V3040D		ISL9V3040D3ST	TO-252A	4	330mm	16mm		2500	
V3040S		ISL9V3040S3ST	TO-263AE	3	330mm	2	4mm	mm 800	
V3040P I		ISL9V3040P3	TO-220AB		Tube	N/A		50	
V304	0S	ISL9V3040S3	TO-262A	\ Tube		N/A		50	
V3040D		ISL9V3040D3S	TO-252AA		Tube	N/A		75	
V3040S ISL9V3040S3S TO			TO-263AE	63AB Tube		N/A		50	
lectrica	al Chai	racteristics T _A = 25°C	unless oth	erwise n	oted				
Symbol		Parameter	Т	est Con	ditions	Min	Тур	Max	Unit
off State	Charact	eristics							
BV _{CER}	Collector to Emitter Breakdown Voltage			$I_C = 2mA, V_{GE} = 0,$			400	430	V
				$R_G = 1K\Omega$, See Fig. 15					
D\/				$T_J = -40 \text{ to } 150^{\circ}\text{C}$			420	450	V
BV_CES	Collector to Emitter Breakdown Voltage			$I_C = 10 \text{mA}, V_{GE} = 0,$ $R_G = 0, \text{ See Fig. 15}$			420	430	V
				$T_J = -40 \text{ to } 150^{\circ}\text{C}$					
BV _{ECS}	Emitter to Collector Breakdown Voltage			$I_C = -75 \text{mA}, V_{GE} = 0 \text{V},$		30	-	-	V
				$T_C = 25^{\circ}C$					
BV _{GES}	Gate to E		± 2mA	T 0500	±12	±14	-	V	
I _{CER}	Collector	to Emitter Leakage Current	V _{CER} = R _G = 1	= 250V, KO	$T_{\rm C} = 25^{\circ}{\rm C}$	-	-	25	μA
			See Fi		T _C = 150°C	-	-	1	mA
I _{ECS}	Emitter to	o Collector Leakage Current	V _{EC} = 2	24V, See	T _C = 25°C	-	-	1	mA
			Fig. 11		T _C = 150°C	-	-	40	mA
R ₁	Series G	ate Resistance				-	70	-	Ω
R ₂	Gate to E	Emitter Resistance				10K	-	26K	Ω
n State	Charact	eristics							
V _{CE(SAT)}	Collector	to Emitter Saturation Voltag			T _C = 25°C,	-	1.25	1.60	V
			V _{GE} = 4		See Fig. 3				
$V_{CE(SAT)}$	Collector to Emitter Saturation Voltage)A,	T _C = 150°C,	-	1.58	1.80	V
1/	Collector	to Emittor Saturation Valtac	V _{GE} = 4		See Fig. 4 T _C = 150°C		1.90	2.20	V
$V_{CE(SAT)}$	Collector to Emitter Saturation Voltage		$I_C = 15$ $V_{GE} = 6$		1C - 150 C	-	1.90	2.20	V
ynamic	Charact	eristics							
Q _{G(ON)}	Gate Ch	arge	I _C = 10	A, V _{CE} :	= 12V,	-	17	-	nC
			V _{GE} =	5V, See					
$V_{GE(TH)}$	Gate to I	Emitter Threshold Voltage	$I_{\rm C} = 1.0$		T _C = 25°C	1.3	-	2.2	V
			V _{CE} = ' See Fi		T _C = 150°C	0.75	-	1.8	V
V_{GEP}	Gate to I	Emitter Plateau Voltage		A, V _{CE} :	= 12V	-	3.0	-	V
witching	Charac	teristics							
t _{d(ON)R}	Current	Turn-On Delay Time-Resistiv	ve V _{CF} =	V _{CE} = 14V, R _L = 1Ω,		-	0.7	4	μs
t _{rR}	Current Rise Time-Resistive		V _{GE} = :	V_{GE} = 5V, R_G = 1K Ω T _J = 25°C, See Fig. 12		-	2.1	7	μs
t _{d(OFF)L}		Turn-Off Delay Time-Inductive		$V_{CE} = 300V, L = 500\mu Hy,$		-	4.8	15	μs
t_fL	Current	Fall Time-Inductive		V_{GE} = 5V, R _G = 1KΩ T _J = 25°C, See Fig. 12		-	2.8	15	μs
SCIS	Self Clamped Inductive Switching			$T_{,l} = 25^{\circ}C, L = 3.0 \text{ mHy},$		-	-	300	mJ
-				$R_G = 1K\Omega$, $V_{GE} = 5V$, See					
			Fig. 1 8	& 2					
hermal (Characte	eristics							
$R_{\theta JC}$		Resistance Junction-Case	All pac	kages		_	-	1.0	°C/\
000	1		F	J -		1		1	1

Typical Performance Curves

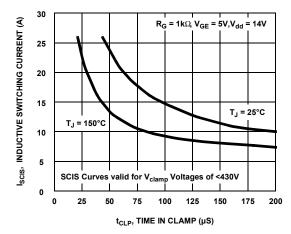


Figure 1. Self Clamped Inductive Switching Current vs Time in Clamp

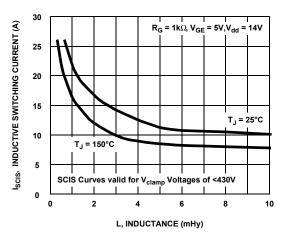


Figure 2. Self Clamped Inductive Switching Current vs Inductance

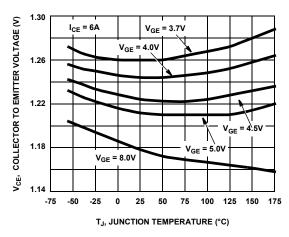


Figure 3. Collector to Emitter On-State Voltage vs Junction Temperature

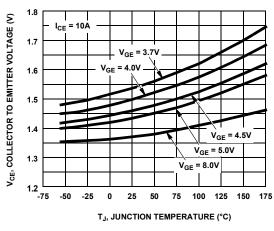


Figure 4. Collector to Emitter On-State Voltage vs Junction Temperature

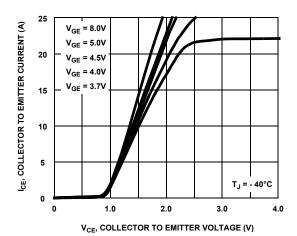


Figure 5. Collector to Emitter On-State Voltage vs Collector Current

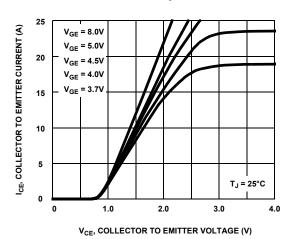
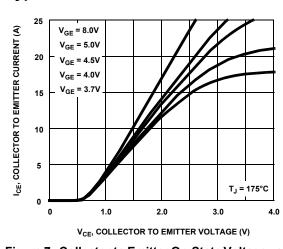
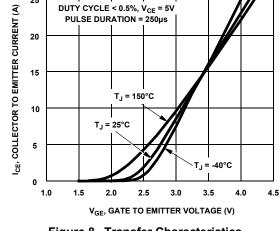


Figure 6. Collector to Emitter On-State Voltage vs Collector Current



Typical Performance Curves (Continued)

Figure 7. Collector to Emitter On-State Voltage vs Collector Current



25

Figure 8. Transfer Characteristics

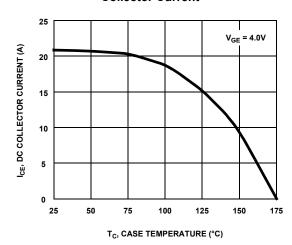


Figure 9. DC Collector Current vs Case Temperature

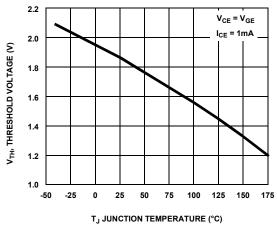


Figure 10. Threshold Voltage vs Junction Temperature

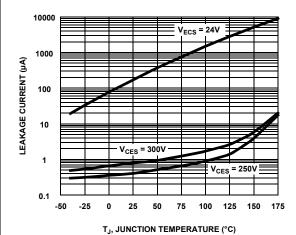


Figure 11. Leakage Current vs Junction Temperature

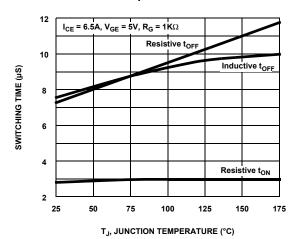


Figure 12. Switching Time vs Junction Temperature

1600 FREQUENCY = 1 MHz 1200 C_{IES} 800 C_{RES} C_{OES} 0 5 10 15 20 25 V_{CE}, COLLECTOR TO EMITTER VOLTAGE (V)

Typical Performance Curves (Continued)

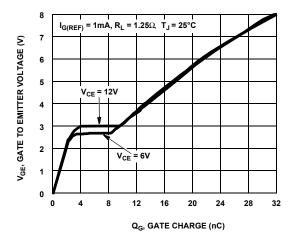


Figure 13. Capacitance vs Collector to Emitter Voltage

Figure 14. Gate Charge

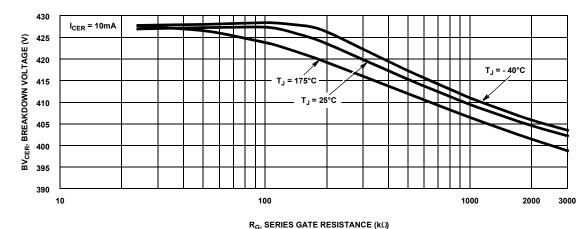


Figure 15. Breakdown Voltage vs Series Gate Resistance

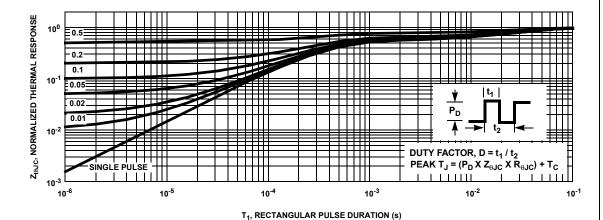
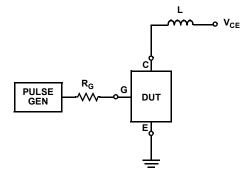


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

Test Circuit and Waveforms



 $R_{G} = 1K\Omega$ G DUT V_{CE}

Figure 17. Inductive Switching Test Circuit

Figure 18. t_{ON} and t_{OFF} Switching Test Circuit

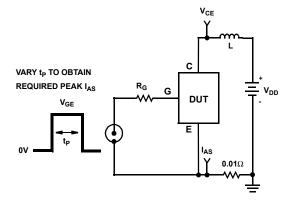


Figure 19. Energy Test Circuit

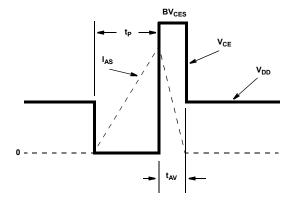


Figure 20. Energy Waveforms

SPICE Thermal Model REV 7 March 2002 JUNCTION ISL9V3040D3S / ISL9V3040S3S / ISL9V3040P3 / ISL9V3040S3 CTHERM1 th 6 2.1e -3 CTHERM2 6 5 1.4e -1 CTHERM3 5 4 7.3e -3 CTHERM4 4 3 2.1e -1 RTHERM1 CTHERM1 CTHERM5 3 2 1.1e -1 CTHERM6 2 tl 6.2e +6 RTHERM1 th 6 1.2e -1 6 RTHERM2 6 5 1.9e -1 RTHERM3 5 4 2.2e -1 RTHERM4 4 3 6.0e -2 RTHERM2 CTHERM2 RTHERM5 3 2 5.8e -2 RTHERM6 2 tl 1.6e -3 SABER Thermal Model 5 SABER thermal model ISL9V3040D3S / ISL9V3040S3S / ISL9V3040P3 / ISL9V3040S3 RTHERM3 CTHERM3 template thermal_model th tl thermal_c th, tl 4 ctherm.ctherm1 th 6 = 2.1e - 3ctherm.ctherm2 6 5 = 1.4e -1 ctherm.ctherm3 5 4 = 7.3e - 3ctherm.ctherm4 4 3 = 2.2e -1 RTHERM4 CTHERM4 ctherm.ctherm5 3 2 =1.1e -1 ctherm.ctherm6 2 tl = 6.2e +6 rtherm.rtherm1 th 6 = 1.2e -1 3 rtherm.rtherm2 6 5 = 1.9e-1rtherm.rtherm3 5 4 = 2.2e -1 rtherm.rtherm4 4 3 = 6.0e -2 RTHERM5 CTHERM5 rtherm.rtherm5 3 2 = 5.8e -2 rtherm.rtherm6 2 tl = 1.6e -3 2 RTHERM6 CTHERM6

CASE

tl





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Definition of Terms

Definition of Terms							
Datasheet Identification	Product Status	Definition					
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.					
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.					
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